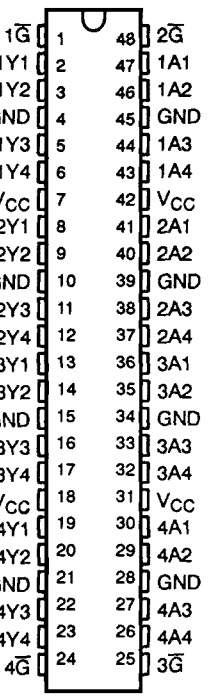
- **Member of the Texas Instruments *Widebus*™ Family**
- **Packaged in Shrink Small-Outline 300-mil Package Using 25-mil Center-to-Center Pin Spacings**
- **3-State Outputs Drive Bus Lines or Buffer Memory Address Registers**
- **Flow-Through Architecture Optimizes PCB Layout**
- **Distributed V_{CC} and GND Configuration Minimizes High-Speed Switching Noise**
- ***EPIC*™ (Enhanced-Performance Implanted CMOS) 1-μm Process**
- **500-mA Typical Latch-Up Immunity at 125°C**
- **Packaged in Plastic Shrink and Plastic Thin Shrink Small-Outline Packages Using 25-mil Center-to-Center Pin Spacings**

DGG OR DL PACKAGE
(TOP VIEW)



description

The 74AC16244 is a 16-bit buffer/line driver designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer. This device provides true outputs and symmetrical $\overline{G}$ (active-low) output-enable inputs.

The 74AC16244 is packaged in the TI's shrink small-outline package (SSOP), which provides twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

The 74AC16244 is characterized for operation from – 40°C to 85°C.

FUNCTION TABLE
(each driver)

INPUTS		OUTPUT
$\overline{G}$	A	Y
L	H	H
L	L	L
H	X	Z

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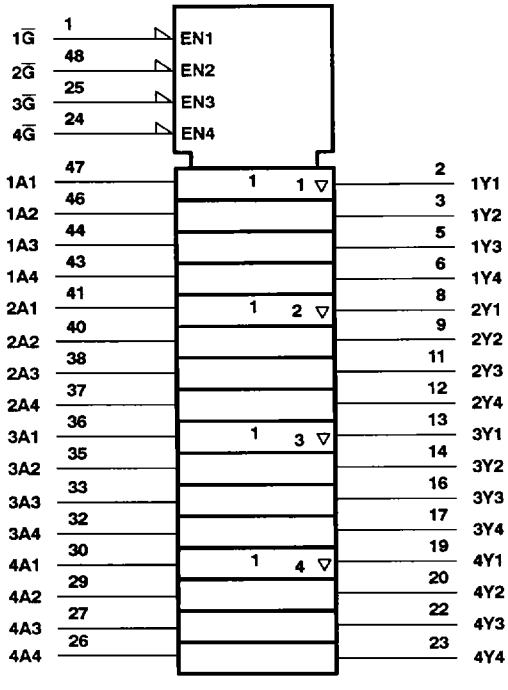
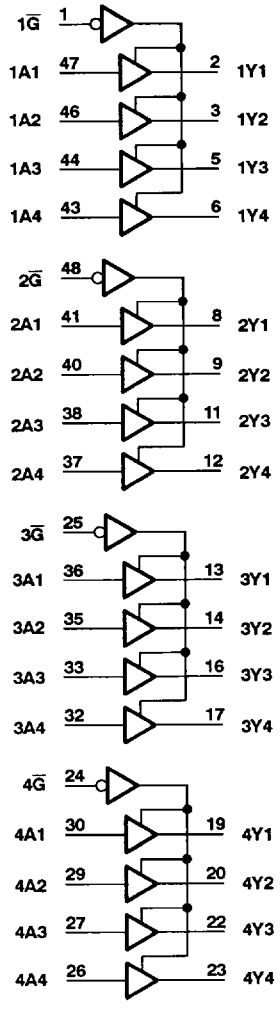
logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} ..... – 0.5 V to 7 V
Input voltage range, V_I (see Note 1) ..... – 0.5 V to V_{CC} + 0.5 V
Output voltage range, V_O (see Note 1) ..... – 0.5 V to V_{CC} + 0.5 V
Input clamp current, I_{IK} (V_I < 0 or V_I > V_{CC}) ..... ± 20 mA
Output clamp current, I_{OK} (V_O < 0 or V_O > V_{CC}) ..... ± 50 mA
Continuous output current, I_O (V_O = 0 to V_{CC}) ..... ± 50 mA
Continuous current through V_{CC} or GND ..... ± 400 mA
Storage temperature range ..... – 65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions (see Note 2)

			MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage (see Note 3)		3	5	5.5	V
V_{IH}	High-level input voltage	V_{CC} = 3 V	2.1			V
		V_{CC} = 4.5 V	3.15			
		V_{CC} = 5.5 V	3.85			
V_{IL}	Low-level input voltage	V_{CC} = 3 V			0.9	V
		V_{CC} = 4.5 V			1.35	
		V_{CC} = 5.5 V			1.65	
V_I	Input voltage		0		V_{CC}	V
V_O	Output voltage		0		V_{CC}	V
I_{OH}	High-level output current	V_{CC} = 3 V			–4	mA
		V_{CC} = 4.5 V			–24	
		V_{CC} = 5.5 V			–24	
I_{OL}	Low-level output current	V_{CC} = 3 V			12	mA
		V_{CC} = 4.5 V			24	
		V_{CC} = 5.5 V			24	
$\Delta t/\Delta v$	Input transition rise or fall rate		0		10	ns/V
T_A	Operating free-air temperature		–40		85	°C

NOTES: 2. Unused or floating inputs should be tied to V_{CC} through a pullup resistor of approximately 5 kΩ or greater.
3. All V_{CC} and GND pins must be connected to the proper voltage supply.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V_{CC}	T_A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
V_{OH}	I_{OH} = −50 μA	3 V	2.9			2.9		V
		4.5 V	4.4			4.4		
		5.5 V	5.4			5.4		
	I_{OH} = −4 mA	3 V	2.58			2.48		
	I_{OH} = −24 mA	4.5 V	3.94			3.8		
		5.5 V	4.94			4.8		
	I_{OH} = −75 mA†	5.5 V				3.85		
V_{OL}	I_{OL} = −50 μA	3 V			0.1		0.1	V
		4.5 V			0.1		0.1	
		5.5 V			0.1		0.1	
	I_{OL} = 12 mA	3 V			0.36		0.44	
	I_{OL} = 24 mA	4.5 V			0.36		0.44	
		5.5 V			0.36		0.44	
	I_{OL} = 75 mA†	5.5 V					1.65	
I_I	V_I = V_{CC} or GND	5.5 V			±0.1		±1	μA
I_{OZ}	V_I = V_{CC} or GND	5.5 V			±0.5		±5	μA
I_{CC}	V_I = V_{CC} or GND, I_O = 0	5.5 V			8		80	μA
C_i	V_I = V_{CC} or GND	5 V		4.5				pF
C_o	V_I = V_{CC} or GND	5 V		12				

† Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V ± 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T_A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
t_{PLH}	A	Y	2	7.1	9.4	2	10.8	ns
t_{PHL}			2.4	8.3	10.7	2.4	11.8	
t_{PZH}	$\overline{G}$	Y	2.2	7.5	10	2.2	11.5	ns
t_{PZL}			2.9	10.4	13	2.9	14.6	
t_{PHZ}	$\overline{G}$	Y	4.1	6.8	8.4	4.1	9.1	ns
t_{PLZ}			3.7	6.5	8.1	3.7	8.8	

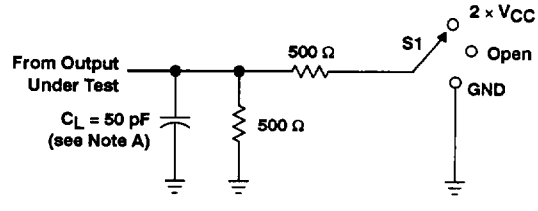
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	T_A = 25°C			MIN	MAX	UNIT
			MIN	TYP	MAX			
t_{PLH}	A	Y	1.6	4.6	6.3	1.6	7.1	ns
t_{PHL}			2	5.3	7	2	7.9	
t_{PZH}	$\overline{G}$	Y	1.7	4.8	6.7	1.7	7.5	ns
t_{PZL}			2.2	6.1	8.1	2.2	9	
t_{PHZ}	$\overline{G}$	Y	4	6.4	7.8	4	8.4	ns
t_{PLZ}			3.5	5.5	7.2	3.5	7.6	

operating characteristics, V_{CC} = 5 V, T_A = 25°C

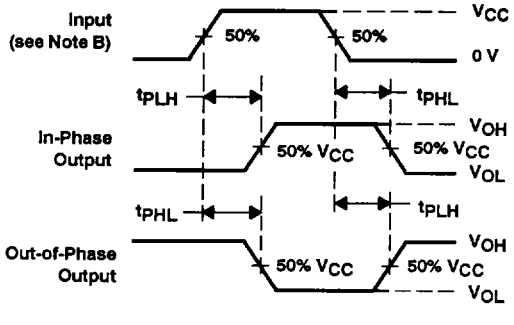
PARAMETER			TEST CONDITIONS	TYP	UNIT
C_{pd}	Power dissipation capacitance per latch	Outputs enabled	C_L = 50 pF, f = 1 MHz	43	pF
		Outputs disabled		7	

PARAMETER MEASUREMENT INFORMATION

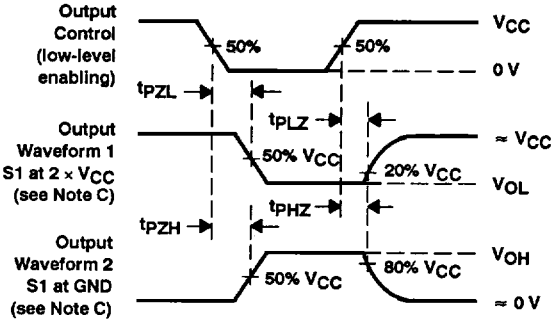


LOAD CIRCUIT

TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	2 × V_{CC}
t_{PHZ}/t_{PZH}	GND



VOLTAGE WAVEFORMS



VOLTAGE WAVEFORMS

NOTES: A. C_L includes probe and jig capacitance.
B. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z_O = 50 Ω, t_r = 3 ns, t_f = 3 ns.
C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms